



**MIRROR BLANK MATERIAL, ALIGO LARGE TELESCOPE MIRROR**

AUTHOR:	CHECKED:	DATE	APPROVALS		
			DCN NO.	REV	DATE
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**Applicable Documents**

D070088-00-D ALIGO Large Telescope Mirror Blank  
MIL-G-174-B Glass, Optical

**Requirements**

Physical Dimensions	Per D070088-00-D ALIGO Large Telescope Mirror Blank
Diameter	271 mm, +1 mm, -0 mm
Thickness	106 mm, +1 mm, -0 mm
Clear Aperture	Central 260 mm
Serial Number	Blanks shall be serialized as MMT3-XX, where XX increments starting at 01
Material	BK7
Final Shaping	Shaping shall be performed using a progression of grit size ending with a 320 or smaller grit wheel
Defect Depth	Maximum on any surface or corner is less than 0.5 mm
Homogeneity	$\leq 5 \times 10^{-6}$ peak to valley at $\lambda = 632.8$ nm, within the central 200 mm
Birefringence	$\leq 5$ nm/cm within the central 200 mm
Bubble and inclusion cross section within clear aperture	Total $\leq 0.25$ mm <sup>2</sup> /100 cm <sup>3</sup> of glass Inclusions with a diameter of 0.06 mm or less are disregarded Maximum inclusion diameter $\leq 0.1$ mm $\leq 0.03$ mm <sup>2</sup> /100 cm <sup>3</sup> in region 10 mm down from surface of side 1
Striae within the clear aperture	Grade A according to MIL-G-174
Absorption	$< 50$ parts per million per centimeter at $\lambda=1.06$ $\mu$ m (lowest absorption)



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Table 1: Measurement Matrix - Frequency and Method

Specification	Test Method	Frequency of Inspection	Data Delivered
Physical Dimensions	Visual Inspection	100%	Diameter, Thickness
Serial Number	Visual Inspection	100%	Inspection Report included with Certification
Material	Process Control Material Certification	100%	Certification
Defect Depth	Visual Inspection	100%	Certification
Homogeneity	Interferometric Measurement	100%	Certification
Birefringence	MIL-G-174, Section 4.4.5	100%	Inspection Report included with Certification
Inclusions	Visual Inspections	100%	Hand sketch indicating location, depth, and dimensions
Striae	MIL-G-174, Section 4.4.5, method 1 or 2 (in optical axis only)	100%	Certification
Absorption at 1.06 μm	Material Certification	100%	Certification